

<b>Notice of References Cited</b>	Application/Control No. 10/529,180		Applicant(s)/Patent Under Reexamination TAKAHASHI ET AL.	
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*	B	US-6,191,187	02-2001	Yamamura et al.	522/96
*	C	US-7,125,601	10-2006	Pinault et al.	428/143
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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